

# **PRODUCT DISCONTINUANCE NOTIFICATION**

EOL-000114 Date: 5APR2016

P1/3

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#### Product Discontinuance Details

#### Purpose, Description and Effect of Change:

This notification is to inform your company that Semtech is discontinuing the manufacture of the products listed below. In accordance with Semtech's product discontinuation policy, we are hereby giving notice of these product changes in order for your company to make any final lifetime purchases of the discontinued product that are still in supply.

Products purchased under EOL are subject to No Credit/No Return and are exempt from On-going FA support.

Product Status: Q Status

Part Number(s) Affecte μClamp0551Y.TFT RClamp1851Y.TFT RClamp3331Y.TFT RClamp2451Y.TFT	∍d:	Customer Part Numbe	r <b>(s) Affected:</b> ⊠ N/A
Replacement or Altern		N/A or Not Offered	
μClamp0551Y.TFT -> μ			
RClamp1851Y.TFT -> F			
RClamp3331Y.TFT -> F			
RClamp2451Y.TFT -> F	Clamp2451ZATFT		
Last Time Buy (LTB) Date	2OCT2016	Must Accept Final Delivery by	31MAR2017
Sample Availability	5APR2016	Qualification Report	5APR2016
of Alt. Part	□ N/A	Availability of Alt. Part	□ N/A
μClamp5011ZA: Produ RClamp1851ZA: Produ RClamp3331ZA: Produ	s for Alternate or Repla uct Data Sheet and Qua uct Data Sheet and Qua uct Data Sheet and Qua uct Data Sheet and Qua	lification Report lification Report lification Report	ents:



# **PRODUCT DISCONTINUANCE NOTIFICATION**

EOL-000114 Date: 5APR2016

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#### **Last Time Buy Conditions**

We request you carefully review this information and notify your purchasing offices and buyers to place your company's final purchases for available discontinued products as soon as possible according to the following last time buy terms and conditions.

- Availability: The Last Time Buy Date and Date to Accept Final Delivery are noted above. All
  orders must have a requested ship date before the Date to Accept Final Delivery or the order will
  be rejected. The Last Time Buy Date automatically expires when the final available inventory
  quantity has been scheduled and sold.
- 2. **Pricing:** The product unit price will be subject to Semtech's individual price quotation of your company's last time buy requirements.
- 3. Order Acceptance/Change Conditions:
  - A. Semtech will accept last time orders from your company for the discontinued products as "Firm and Final". As such, these orders will not be subject to any reschedule, cancellation, or termination by your company without Semtech's prior written authorization and payment of full termination charges.
  - B. Semtech reserves its right to make changes in the scheduled delivery dates, or to terminate remaining undelivered quantities of your company's last time buy order, due to changes in Semtech's last time manufacturing capabilities, or for commercially impracticable circumstances which makes delivery not feasible.
- 4. Quantities: The following applies to final buy quantities for the available discontinued product:
  - A. **First:** The quantities in any existing unfilled orders and contracts acknowledged by Semtech will be honored, then
  - B. **Next:** The unfilled quantities in any volume agreement(s) or quantities in unexpired standalone quote(s) will be accepted, and
  - C. **Finally:** Any additional reasonable quantity of product that Semtech quotes based upon your company's identified requirements will be taken.

IN THE EVENT OF CONFLICT FOR THE LIMITED AVAILABILITY PRODUCT, QUANTITIES FOR CUSTOMER'S OR DISTRIBUTOR'S ORDERS WILL BE DETERMINED ON A FIRST-COME FIRST-SERVE BASIS; AND WILL BE SUBJECT TO SEMTECH'S AVAILABLE INVENTORY AND REMAINING MANUFACTURING CAPACITY FOR THE PRODUCT.



# **PRODUCT DISCONTINUANCE NOTIFICATION**

#### EOL-000114 Date: 5APR2016

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#### **Limited Warranty**

All discontinued product orders subject to this notice shall carry Semtech's standard limited warranty; or, if applicable, the warranty set forth in a duly executed formal contract between Semtech and your company will apply; except that:

- 1. Semtech will accept all valid warranty claims for credit only, unless a replacement order is otherwise agreed upon by Semtech and the replacement parts can be manufactured or delivered from remaining inventory.
- 2. The applicable warranty period for making any return claims for discontinued products will be no later than ninety (90) days following delivery of the discontinued products.
- 3. Any return claims must be made under Semtech's current Return Material Authorization "RMA" procedures.

#### **Additional Provisions**

SEMTECH ACCEPTS NO LIABILITY FOR EXCESS REPROCUREMENT COSTS OR FOR ANY SPECIAL, INCIDENTAL, OR CONSEQUENTIAL DAMAGES WHATSOEVER ASSOCIATED WITH THIS NOTICE, WITH ITS PRODUCTS, OR WITH THE FINAL MANUFACTURE AND PERFORMANCE AGAINST ANY LAST TIME BUY ORDERS RELATED TO THE DISCONTINUED PRODUCTS COVERED BY THIS NOTICE.

We regret the inconvenience and impact this notice may cause your company. Semtech's sales, marketing, and distribution personnel stand ready to assist you in placing your company's final orders, or in providing the product information you require.

For product inquiries or purchase order information, please contact your local Semtech sales representative.

Issuing Authority						
Semtech Business Unit:	Protection Business Unit					
Semtech Contact Info:	Les Fang Yuen Senior Manager, Quality Assurance Semtech Corporation <u>Ifangyen@semtech.com</u> ; Office: +1 949-269-4443	Les Long yuen				
FOR FURTHER INFORMATION & WORLDWIDE SALES COVERAGE: http://www.semtech.com/contact/index.html#support						



# **PROTECTION PRODUCTS - RailClamp®**

### Description

RClamp<sup>®</sup> TVS diodes are designed to protect sensitive electronics from damage or latch-up due to ESD. They are designed to replace multilayer varistors (MLVs) in portable applications such as cell phones, notebook computers, and other portable electronics. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp<sup>®</sup>1851ZA is specifically designed for protection of Near Field Communications (NFC) interfaces. It features extremely good ESD protection characteristics including a low typical dynamic resistance of 0.16 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-17kV contact per IEC 61000-4-2). Low typical capacitance (0.35pF at VR=0V) means that harmonic distortion the the RF signal is minimized. This device is bidirectional and has a working voltage of 18V for use on NFC resonator circuits without signal clipping.

RClamp1851ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of only 0.25mm. Leads are finished with NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and tablet PC's.

### **Features**

- High ESD withstand Voltage: +/-17kV (Contact) and +/- 20kV (Air) per IEC 61000-4-2
- Ultra-small package
- Protects one high speed data line
- Low ESD clamping voltage
- Working voltage: 18V
- Low capacitance: 0.35pF typical
- Low leakage current
- Extremely low dynamic resistance: 0.16 Ohms (Typ)
- Solid-state silicon-avalanche technology

#### **Mechanical Characteristics**

- SLP0603P2X3F package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking code
- Packaging: Tape and Reel

### Applications

- Near Field Communication (NFC) lines
- RF signal lines
- Cellular Handsets
- Tablets
- FM Antenna

## **Package Dimensions**



# **Schematic & Pin Configuration**



SLP0603P2X3F (Bottom View)

#### 4/15/2015

# RClamp1851ZA

# **PROTECTION PRODUCTS**

### Absolute Maximum Ratings

SEMTECH

Rating	Symbol	Value	Units
Peak Pulse Current (tp = 8/20µs)	I <sub>PP</sub>	3	A
ESD per IEC 61000-4-2 (Air) <sup>(1)</sup> ESD per IEC 61000-4-2 (Contact) <sup>(1)</sup>	V <sub>ESD</sub>	±20 ±17	kV
Operating Temperature	TJ	-40 to +85	Oo
Storage Temperature	T <sub>stg</sub>	-55 to +150	О°

#### Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Reverse Stand-Off Voltage	V <sub>RWM</sub>	T = -40 to +85°C			18	V
Breakdown Voltage	V <sub>BR</sub>	I <sub>BR</sub> = 10µA	18.5	22.5	26.5	V
Reverse Leakage Current	I <sub>R</sub>	V <sub>RWM</sub> = 18V		<1	50	nA
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	$I_{PP} = 4A$ tp = 0.2/100ns		5.5		V
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	I <sub>pp</sub> = 16A tp = 0.2/100ns		7.5		V
Dynamic Resistance <sup>2, 3</sup>	R <sub>dyn</sub>	tp = 0.2/100ns		0.16		Ohms
Junction Capacitance	Cj	VR = OV; f = 1MHz		0.35	0.45	pF

Notes

1)Measured with a 40dB attenuator, 50 Ohm scope input impedance, 2GHz bandwidth. ESD gun return path connected to ESD ground plane.

2)Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns,  $I_{TLP}$  and  $V_{TLP}$  averaging window: t1 = 70ns to t2 = 90ns.

3)Dynamic resistance calculated from  $I_{TLP} = 4A$  to  $I_{TLP} = 16A$ 

4) Device is electrically symmetrical

# RClamp1851ZA



# PROTECTION PRODUCTS

**Typical Characteristics** 

#### ESD Clamping (8kV Contact per IEC 61000-4-2)



**TLP Characteristic (Positive Pulse)** 



**Capacitance vs. Reverse Voltage** 



ESD Clamping (-8kV Contact per IEC 61000-4-2)



**TLP Characteristic (Negative Pulse)** 



Insertion Loss - S21 (dB)





## **Applications Information**

#### **ESD Protection of NFC Interfaces**

The Near Field Communication (NFC) antenna is usually connected to the NFC controller IC via contact points on the phone. These contact points are user accessable and therefore may be subjected to ESD strikes. External protection (TVS) devices should be placed between the antenna and the NFC chip interface. The working voltage of the TVS should be high enough as not to clip the NFC signal. Additionaly, the capacitance of the device

should be minimized in order to avoid harmonic disctortion of the RF signal. RClamp1851ZA meets these requirements and also features extremely low dynamic resistance resulting in low ESD clamping voltage. The low dynamic resistance also helps insure protection for Schottky diodes that may be used in the NFC circuit. RClamp1851ZA is designed to work on NFC circuits with AC signals as high as 18V. An example protection ciruit is shown below in Figure 1.



Figure 1 - NFC Protection Example



### **Applications Information**

#### **Assembly Guidelines**

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joint. The table below provides Semtech's recommended assembly guidelines for mounting this device. The figure at the right details Semtech's recommended aperture based on the below recommendations. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. The exact manufacturing parameters will require some experimentation to get the desired solder application.

Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



#### **Recommended Mounting Pattern**



# RClamp1851ZA

# **PROTECTION PRODUCTS**

# Outline Drawing - SLP0603P2X3F



# Land Pattern - SLP0603P2X3F





# RClamp1851ZA

# **PROTECTION PRODUCTS**

# Marking



#### Notes: Device is Electrically Symmetrical

### **Tape and Reel Specification**

# **Ordering Information**

Part Number	Qty per Reel	Reel Size
RClamp1851ZATFT	15000	7"

Notes:

1) RailClamp and RClamp are trademarks of Semtech Corporation.



# **Contact Information**

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804



# PROTECTION PRODUCTS - RailClamp<sup>®</sup> Description

RailClamp<sup>®</sup> TVS diodes are ultra low capacitance devices designed to protect sensitive electronics from damage or latch-up due to ESD, EFT, and EOS. They are designed for use on high speed ports in applications such as cell phones, notebook computers, and other portable electronics. These devices offer desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp<sup>®</sup>2451ZA is specifically designed for protection of Near Field Communications (NFC) interfaces. It features extremely good ESD protection characteristics including a low typical dynamic resistance of 0.16 Ohms (typical), low peak ESD clamping voltage, and high ESD withstand voltage (+/-14kV contact per IEC 61000-4-2). Low typical capacitance (0.35pF at VR=0V) means that RClamp2451ZA will not create harmonic distortion in the RF signal. This device is bidirectional and has a working voltage of 24V for use on NFC resonator circuits without signal clipping.

RClamp2451ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of 0.25mm. Leads are finished with lead-free NiAu. The combination of working voltage, low dynamic resistance, and low capacitance makes this device ideal for use on NFC antenna ciruits, RF signal lines, and FM antennas in portable devices.

#### Features

- High ESD withstand Voltage: +/-14kV (Contact) and +/- 18kV (Air) per IEC 61000-4-2
- Able to withstand over 1000 ESD strikes per IEC 61000-4-2 Level 4
- Ultra-small 0201 package
- Protects one high speed data line
- Working voltage: +/- 24V
- Low capacitance: 0.35pF typical
- Low dynamic resistance: 0.16 Ohms (Typ)
- Low ESD clamping voltage
- Solid-state silicon-avalanche technology

#### Mechanical Characteristics

- SLP0603P2X3F Package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- ◆ Lead Finish: NiAu
- ◆ Marking: Marking Code
- Packaging: Tape and Reel

#### **Applications**

- Near Field Communication (NFC) lines
- RF signal lines
- FM Antenna

#### **Nominal Dimensions**



# Schematic



# SEMTECH

### **PROTECTION PRODUCTS**

Absolute Maximum Rating			
Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20µs)	P <sub>pk</sub>	60	Watts
Maximum Peak Pulse Current (tp = 8/20µs)	l <sub>pp</sub>	3	Amps
ESD per IEC 61000-4-2 (Air) <sup>1</sup> ESD per IEC 61000-4-2 (Contact) <sup>1</sup>	V <sub>ESD</sub>	+/- 18 +/- 14	kV
Operating Temperature	T,	-40 to +85	°C
Storage Temperature	T <sub>STG</sub>	-55 to +150	°C

# Electrical Characteristics (T=25°C)

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units
Reverse Stand-Off Voltage	V <sub>RWM</sub>	Pin 1 to 2 or 2 to 1			24	V
Breakdown Voltage	V <sub>BR</sub>	I <sub>BR</sub> = 10µA	25.5	27.5	31	V
Reverse Leakage Current	I <sub>R</sub>	V <sub>RWM</sub> = 24V, T=25°C Pin 1 to 2 or 2 to 1		<1	50	nA
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	I <sub>PP</sub> = 4A, tlp = 0.2/100ns		5		V
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	I <sub>pp</sub> = 16A, tlp = 0.2/100ns		7		V
Dynamic Resistance <sup>2, 3</sup>	R <sub>D</sub>	tp = 0.2/100ns		0.16		Ohms
Junction Capacitance	C <sub>j</sub>	V <sub>R</sub> = OV, f = 1MHz		0.35	0.45	pF

Notes

1)ESD gun return path connected to ESD ground reference plane.

2)Transmission Line Pulse Test (TLP) Settings:  $t_p = 100ns$ ,  $t_r = 0.2ns$ ,  $I_{TLP}$  and  $V_{TLP}$  averaging window:  $t_1 = 70ns$  to  $t_2 = 90ns$ .

 $\overline{3}$ ) Dynamic resistance calculated from I<sub>TLP</sub> = 4A to I<sub>TLP</sub> = 16A



#### **Typical Characteristics**

#### ESD Clamping (+8kV Contact per IEC 61000-4-2)



#### **TLP Characteristic (Positive)**



#### Junction Capacitance vs. Reverse Voltage



ESD Clamping (-8kV Contact per IEC 61000-4-2)



**TLP Characteristic (Negative)** 



#### **Typical Insertion Loss (S21)**





### **Applications Information**

#### **ESD Protection of NFC Interfaces**

The Near Field Communication (NFC) antenna is usually connected to the NFC controller IC via contact points on the phone. These contact points are user accessable and therefore may be subjected to ESD strikes. External protection (TVS) devices should be placed between the antenna and the NFC chip interface. The working voltage of the TVS should be high enough as not to clip the NFC signal. Additionally, the capacitance of the device should be minimized in order to avoid harmonic distortion of the RF signal. RClamp2451ZA meets these requirements and also features extremely low dynamic resistance (<0.1 Ohms) resulting in low ESD clamping voltage. The low dynamic resistance also helps insure protection for Schottky diodes that may be used in the NFC circuit. RClamp2451ZA is designed to work on NFC circuits with AC signals as high as 24V. An example protection ciruit using RClamp2451ZA is shown below in Figure 1.







### Applications Information

#### **Assembly Guidelines**

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joints. The figure at the right details Semtech's recommended aperture based on the assembly guidelines detailed in the table below. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application.

Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



#### **Recommended Mounting Pattern**





## Outline Drawing - SLP0603P2X3F



# Land Pattern - SLP0603P2X3F





# RClamp2451ZA

# PROTECTION PRODUCTS

Marking Code

# Ordering Information

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Part NumberQty per<br/>ReelPocket<br/>PitchReel<br/>SizeRClamp2451ZATFT15,0002mm7 Inch

Notes:

RailClamp and RClamp are trademarks of Semtech Corporation

Note: Device is electrically symmetrical

# **Carrier Tape Specification**



NOTES: ALL DIMENSIONS IN MILLIMETERS UNLESS OTHERWISE SPECIFIED.



**Device Orientation in Tape** 



# Contact Information

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804



# PROTECTION PRODUCTS - RailClamp<sup>®</sup> Description

RailClamp<sup>®</sup> TVS diodes are ultra low capacitance devices designed to protect sensitive electronics from damage or latch-up due to ESD, EFT, and EOS. They are designed for use on high speed ports in applications such as cell phones, notebook computers, and other portable electronics. These devices offer desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

RClamp<sup>®</sup>3331ZA features extremely good ESD protection characteristics including a low typical dynamic resistance of 0.20 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-18kV contact per IEC 61000-4-2). Low typical capacitance (0.35pF at VR=0V) allows the RClamp3331ZA to be used in applications operating in excess of 5GHz without appreciable signal attenuation. Each device will protect one high speed data line operating at 3.3 Volts.

RClamp3331ZA is in a 2-pin SLP0603P2X3F package measuring 0.6 x 0.3 mm with a nominal height of 0.25mm. Leads are finished with lead-free NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of low peak ESD clamping, low dynamic resistance, and low capacitance makes this device suitable for applications such as USB 3.0, MIPI and V-By-One interfaces in portable devices.

#### Features

- High ESD withstand Voltage: +/-18kV (Contact/Air) per IEC 61000-4-2
- Able to withstand over 1000 ESD strikes per IEC 61000-4-2 Level 4
- Ultra-small 0201 package
- Protects one high speed data line
- Working voltage: +/- 3.3V
- Low capacitance: 0.35pF typical
- Extremely low dynamic resistance: 0.20 Ohms (Typ)
- Low ESD clamping voltage
- Solid-state silicon-avalanche technology

#### Mechanical Characteristics

- SLP0603P2X3F Package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking Code
- Packaging: Tape and Reel

#### Applications

- ♦ USB 2.0 / USB 3.0
- MIPI / MDDI
- V-By-One
- eDP
- MHL
- LVDS

#### **Nominal Dimensions**



## Schematic



# SEMTECH

### **PROTECTION PRODUCTS**

Absolute Maximum Rating			
Rating	Symbol	Value	Units
Peak Pulse Power (tp = $8/20\mu s$ )	P <sub>pk</sub>	30	Watts
Maximum Peak Pulse Current (tp = 8/20µs)	l <sub>pp</sub>	4	Amps
ESD per IEC 61000-4-2 $(Air)^1$ ESD per IEC 61000-4-2 $(Contact)^1$	V <sub>ESD</sub>	+/- 18 +/- 18	kV
Operating Temperature	T,	-40 to +85	°C
Storage Temperature	T <sub>STG</sub>	-55 to +150	°C

# Electrical Characteristics (T=25°C)

Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units
Reverse Stand-Off Voltage	V <sub>RWM</sub>	Pin 1 to 2 or 2 to 1			3.3	V
Breakdown Voltage	V <sub>BR</sub>	I <sub>BR</sub> = 10μΑ Pin 1 to 2 or 2 to 1	5.5	8	10.5	V
Reverse Leakage Current	I <sub>R</sub>	V <sub>RWM</sub> = 3.3V, T=25°C Pin 1 to 2 or 2 to 1		<1	50	nA
Clamping Voltage	V <sub>c</sub>	I <sub>PP</sub> = 1A, tp = 8/20µs Pin 1 to 2 or 2 to 1		3.8	5.5	V
Clamping Voltage	V <sub>c</sub>	I <sub>PP</sub> = 4A, tp = 8/20μs Pin 1 to 2 or 2 to 1		5.5	7.5	V
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	IPP = 4A, tlp = 0.2/100ns		4.5		V
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	IPP = 16A, tlp = 0.2/100ns		7		V
Dynamic Resistance <sup>2, 3</sup>	R <sub>D</sub>	tp = 0.2/100ns		0.20		Ohms
Junction Capacitance	C <sub>j</sub>	V <sub>R</sub> = OV, f = 1MHz		0.35	0.45	pF

#### Notes

1)ESD gun return path connected to ESD ground reference plane.

2)Transmission Line Pulse Test (TLP) Settings:  $t_p = 100ns$ ,  $t_r = 0.2ns$ ,  $I_{TLP}$  and  $V_{TLP}$  averaging window:  $t_1 = 70ns$  to  $t_2 = 90ns$ .

3) Dynamic resistance calculated from  $I_{TLP}$  = 4A to  $I_{TLP}$  = 16A



#### **Typical Characteristics**

#### Non-Repetitive Peak Pulse Power vs. Pulse Time

Clamping Waveform (tp=1.2/50us)



Time (ns)

Time (ns)

# RClamp3331ZA

**Typical Insertion Loss S21** 



# **PROTECTION PRODUCTS**

### **Typical Characteristics**

Junction Capacitance vs. Reverse Voltage





### Applications Information

#### **Assembly Guidelines**

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joints. The figure at the right details Semtech's recommended aperture based on the assembly guidelines detailed in the table below. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application.

Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



#### **Recommended Mounting Pattern**





# Outline Drawing - SLP0603P2X3F



# Land Pattern - SLP0603P2X3F





# RClamp3331ZA

# PROTECTION PRODUCTS

Marking Code

# Ordering Information

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Part NumberQty per<br/>ReelPocket<br/>PitchReel<br/>SizeRClamp3331ZATFT15,0002mm7 Inch

Notes:

RailClamp and RClamp are trademarks of Semtech Corporation

Note: Device is electrically symmetrical

# **Carrier Tape Specification**



NOTES: ALL DIMENSIONS IN MILLIMETERS UNLESS OTHERWISE SPECIFIED.



**Device Orientation in Tape** 



# Contact Information

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804



# PROTECTION PRODUCTS - µClamp®

#### Description

µClamp<sup>®</sup> TVS diodes are designed to protect sensitive electronics from damage or latch-up due to ESD. They are designed to replace 0201 size multilayer varistors (MLVs) in portable applications such as cell phones, notebook computers, and other portable electronics. It features large cross-sectional area junctions for conducting high transient currents. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation.

µClamp®5011ZA features extremely good ESD protection characteristics highlighted by low typical dynamic resistance of 0.15 Ohms, low peak ESD clamping voltage, and high ESD withstand voltage (+/-15kV contact per IEC 61000-4-2). Low maximum capacitance (5pF at VR=0V) minimizes loading on sensitive cirucuits. Each device will protect one data or power line operating at 5 Volts.

 $\mu$ Clamp5011ZA is in a 2-pin SLP0603P2X3F package. It measures 0.6 x 0.3 mm with a nominal height of only 0.25mm. Leads are finished with NiAu. The small package gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and tablet PC's.

#### **Features**

- High ESD withstand Voltage: +/-15kV (Contact) and +/- 18kV (Air) per IEC 61000-4-2
- Ultra-small package
- Protects one data line
- Low ESD clamping voltage
- Working voltage: 5V
- Low capacitance: 5pF maximum
- Low leakage current
- Extremely low dynamic resistance: 0.15 Ohms (Typ)
- Solid-state silicon-avalanche technology

#### **Mechanical Characteristics**

- SLP0603P2X3F package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 0.6 x 0.3 x 0.25 mm
- Lead Finish: NiAu
- Marking: Marking code
- Packaging: Tape and Reel

#### Applications

- Cellular Handsets & Accessories
- Notebook Computers
- Tablet PC
- Portable Instrumentation
- Peripherals

#### **Package Dimensions**



## **Schematic & Pin Configuration**



SLP0603P2X3F (Bottom View)



# Absolute Maximum Ratings

SEMTECH

Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20µs)	Р <sub>рк</sub>	30	W
Peak Pulse Current (tp = 8/20µs)	l <sub>PP</sub>	2.5	А
ESD per IEC 61000-4-2 (Air) <sup>(1)</sup> ESD per IEC 61000-4-2 (Contact) <sup>(1)</sup>	V <sub>ESD</sub>	±18 ±15	kV
Operating Temperature	L_L	-40 to +125	°C
Storage Temperature	T <sub>STG</sub>	-55 to +150	°C

### Electrical Characteristics (T=25°C unless otherwise specified)

Parameter	Symbol	Condit	Min.	Тур.	Max.	Units	
Reverse Stand-Off Voltage	V <sub>RWM</sub>	Pin 1 to 2 or	Pin 2 to 1			5	V
Reverse breakdown Voltage	$V_{_{BR}}$	ו <sub>BR</sub> = 1 Pin 1 to 2 or	mA Pin 2 to 1	6.5	8.5	10.5	V
Reverse Leakage Current	I <sub>R</sub>	V <sub>RWM</sub> = Pin 1 to 2 or	= 5V Pin 2 to 1		5	20	nA
Clamping Voltage	V <sub>c</sub>	I <sub>PP</sub> = 2.5А, tp	o = 8/20µs			12	V
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	I <sub>PP</sub> = 1 tp = 0.2/			8		V
ESD Clamping Voltage <sup>2</sup>	V <sub>c</sub>	I <sub>PP</sub> = 1 tp = 0.2/		9.8		V	
Dynamic Resistance <sup>2, 3</sup>	R <sub>dyn</sub>	tp = 10		0.15		Ohms	
Junction Capacitance	CJ	I/O pin to GND f = 1MHz	V <sub>R</sub> = 0V		4.2	5	pF

Notes

1)Measured with a 20dB attenuator, 50 Ohm scope input impedance, 2GHz bandwidth. ESD gun return path connected to ESD ground plane.

2)Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns,  $I_{TLP}$  and  $V_{TLP}$  averaging window: t1 = 70ns to t2 = 90ns.

3) Dynamic resistance calculated from  $I_{TLP}$  = 4A to  $I_{TLP}$  = 16A



**Typical Characteristics** 

#### ESD Clamping (8kV Contact per IEC 61000-4-2)



#### **TLP Characteristic (Positive Pulse)**







ESD Clamping (-8kV Contact per IEC 61000-4-2)



**TLP Characteristic (Negative Pulse)** 







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# **PROTECTION PRODUCTS**

## **Applications Information**

#### **Assembly Guidelines**

The small size of this device means that some care must be taken during the mounting process to insure reliable solder joint. The table below provides Semtech's recommended assembly guidelines for mounting this device. The figure at the right details Semtech's recommended aperture based on the below recommendations. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. The exact manufacturing parameters will require some experimentation to get the desired solder application.

Assembly Parameter	Recommendation
Solder Stencil Design	Laser cut, Electro-polished
Aperture shape	Rectangular with rounded corners
Solder Stencil Thickness	0.100 mm (0.004")
Solder Paste Type	Type 4 size sphere or smaller
Solder Reflow Profile	Per JEDEC J-STD-020
PCB Solder Pad Design	Non-Solder mask defined
PCB Pad Finish	OSP OR NiAu



#### **Recommended Mounting Pattern**



# **PROTECTION PRODUCTS**

## **Outline Drawing - SLP0603P2X3F**



# Land Pattern - SLP0603P2X3F





# **PROTECTION PRODUCTS**

Notes: Device is Electrically Symmetrical

# Marking



# **Ordering Information**

Part Number	Qty per Reel	Reel Size
µClamp5011ZATFT	15000	7"

Notes:

1) MicroClamp, uClamp and  $\mu Clamp$  are trademarks of Semtech Corporation.



# **Contact Information**

Semtech Corporation Protection Products Division 200 Flynn Rd., Camarillo, CA 93012 Phone: (805)498-2111 FAX (805)498-3804

Businessunit	Protection				
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:	
5878	uClamp0551Z, uClamp5011Z	ASMC12TVS	Rel Testing Complete	Job Accepted: 22-Aug-2014	
	Package (Z1A) Qualification	Z1A	Passes All Requirements	Requested CD:	
		200		Actual Start Date: 27-Aug-2014	
	New Product on qualified process with un- qualified package			ECD for Conditional:	
				Job ECD: 22-Oct-2014	

Completeu Tusks						
.0 Lot EP338580 Assemb	<i>lyLot</i> AER-002012	DateCode	1434			
Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource Results/Comments	
1 Data-Prep	None	None	27-Aug-2014	0	Camarillo	
2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	04-Sep-2014	0	Camarillo	
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	09-Sep-2014	0	Camarillo	
4 HTRB_Pre_Elect	105	Pass on Zero Fails	27-Aug-2014	0	Camarillo	
5 BI_BD_Valid	NA	Meet HTOL Schematics	28-Aug-2014	0	Camarillo	
6 HTRB_150°C_0072	105	Pass on Zero Fails	02-Sep-2014	0	Camarillo	
7 HTRB_150°C _0408	105	Pass on Zero Fails	15-Sep-2014	0	Camarillo	
8 HTS_Pre_Elect	77	Pass on Zero Fails	27-Aug-2014	0	Camarillo	
9 HTS_0168	77	Pass on Zero Fails	03-Sep-2014	0	Camarillo	
10 HTS_0500	77	Pass on Zero Fails	17-Sep-2014	0	Camarillo	
11 HTS_1000	77	Pass on Zero Fails	08-Oct-2014	0	Camarillo	
12 Pre_Conditioning_Level_1	NA	MSL 1	27-Aug-2014	0	Camarillo	
13 Rider_Card_Wash/Bake			27-Aug-2014	0	Camarillo	
14 Pre_Elect_Precond	154	Pass on Zero Fails	28-Aug-2014	0	Camarillo	
15 Precond_Temp_Cyc_5cyc	154	Pass on Zero Fails	28-Aug-2014	0	Camarillo	

# **Completed Tasks**

16 Precond_HTS_24hr	154	Pass on Zero Fails	29-Aug-2014	0	Camarillo	
17 Precond_85/85_NoElec168hr	154	Pass on Zero Fails	05-Sep-2014	0	Camarillo	
18 Precond_260°C_IR_Ref_Char	154	Pass on Zero Fails	05-Sep-2014	0	Camarillo	
19 T/C_Pre_Elect	77	Pass on Zero Fails	05-Sep-2014	0	Camarillo	
20 T/C_wPre_0250	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
21 T/C_wPre_0500	77	Pass on Zero Fails	16-Sep-2014	0	Camarillo	
22 T/C_wPre_1000	77	Pass on Zero Fails	26-Sep-2014	0	Camarillo	
23 85/85_Pre Elec	77	Pass on Zero Fails	04-Sep-2014	0	Camarillo	
24 85/85_Biased_168hr	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo	
25 85/85_on/off500hrs	77	None	26-Sep-2014	0	Camarillo	
26 85/85_on/off_1000hrs	77	None	21-Oct-2014	0	Camarillo	
27 Pack_Clos	0	0	22-Oct-2014	0	Camarillo	
2.0 Lot EP3300.01 AssemblyL	ot AER-002017	DateCode	1435			
	71211002011					
Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
•				<i>Failures</i> 0	DataSource Camarillo	Results/Comments
Seq TaskCode	SampleSize	Criteria	Complete			Results/Comments
Seq TaskCode 1 Data-Prep	SampleSize	Criteria None	Complete 03-Sep-2014	0	Camarillo	Results/Comments
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24	SampleSize None 210	Criteria None Pass on Zero Fails	Complete 03-Sep-2014 10-Sep-2014	0 0	Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024	SampleSize None 210 210	Criteria None Pass on Zero Fails Pass on Zero Fails	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014	0 0 0	Camarillo Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect	SampleSize           None           210           210           105	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014	0 0 0 0	Camarillo Camarillo Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid	SampleSize           None           210           210           105           NA	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014	0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072	SampleSize           None           210           210           105           NA           105	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 08-Sep-2014	0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408	SampleSize           None           210           210           105           NA           105           105           105	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 08-Sep-2014 22-Sep-2014	0 0 0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408 8 HTS_Pre_Elect	SampleSize         None         210         210         105         NA         105         105         77	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 22-Sep-2014 03-Sep-2014	0 0 0 0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408 8 HTS_Pre_Elect 9 HTS_0168	SampleSize           None           210           210           105           NA           105           77           77	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 22-Sep-2014 03-Sep-2014 03-Sep-2014	0 0 0 0 0 0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	<i>Results/Comments</i>
Seq TaskCode 1 Data-Prep 2 HTRB_Pre_Elect_150°C_RT24 3 HTRB_150°C_Real Time_0024 4 HTRB_Pre_Elect 5 BI_BD_Valid 6 HTRB_150°C_0072 7 HTRB_150°C_0408 8 HTS_Pre_Elect 9 HTS_0168 10 HTS_0500	SampleSize         None         210         210         105         NA         105         105         77         77         77         77         77         77         77         77         77	Criteria None Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Meet HTOL Schematics Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails Pass on Zero Fails	Complete 03-Sep-2014 10-Sep-2014 11-Sep-2014 03-Sep-2014 03-Sep-2014 22-Sep-2014 03-Sep-2014 10-Sep-2014 24-Sep-2014	0 0 0 0 0 0 0 0 0 0 0 0	Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo Camarillo	<i>Results/Comments</i>

14 Precond_HTS_24hr	77	Pass on Zero Fails	04-Sep-2014	0	Camarillo	
15 Precond_85/85_NoElec168hr	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
16 Precond_IR_Refl_Char	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
17 T/C_Pre_Elect	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
18 T/C_wPre_0250	77	Pass on Zero Fails	17-Sep-2014	0	Camarillo	
19 T/C_wPre_0500	77	Pass on Zero Fails	22-Sep-2014	0	Camarillo	
20 T/C_wPre_1000	77	Pass on Zero Fails	02-Oct-2014	0	Camarillo	
21 85/85_Pre Elec	77	Pass on Zero Fails	03-Sep-2014	0	Camarillo	
22 85/85_Biased_168hr	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo	
23 85/85_on/off500hrs	77	None	26-Sep-2014	0	Camarillo	
24 85/85_on/off_1000hrs	77	None	21-Oct-2014	0	Camarillo	
25 FA_85/85_0168hr	1	FAs must be resolved, resulting in discounting the failure or corrective action taken.	12-Sep-2014	0	Camarillo	Continued to 500 hrs for further evaluation
26 FA_85/85_0500hr	1	FAs must be resolved, resulting in discounting the failure or corrective action taken.	29-Sep-2014	0	Camarillo	Continuing to 1000 hrs for final evaluation.
27 FA_85/85_1000hr	1	FAs must be resolved, resulting in discounting the failure or corrective action taken.	21-Oct-2014	0	Camarillo	Discounted, borderline passing at T0 marginally shifted due to tester variance.
28 Pack_Clos	0	0	22-Oct-2014	0	Camarillo	
Lot EP3300.01 AssemblyLo	ot AER-002018	DateCode	1435			
Seq TaskCode	SampleSize	Criteria	Complete	Failures	DataSource	Results/Comments
1 Data-Prep	None	None	05-Sep-2014	0	Camarillo	
2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	11-Sep-2014	0	Camarillo	
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	12-Sep-2014	0	Camarillo	

05-Sep-2014

0

Camarillo

Pass on Zero Fails

4 HTRB\_Pre\_Elect

105

3.0

by Sublot, by Sequence Contact: Gurmail Sajjan (805) 480 2142 gsajjan@semtech.com

5 BI_BD_Valid	NA	Meet HTOL Schematics	05-Sep-2014	0	Camarillo
6 HTRB_150°C_0072	105	Pass on Zero Fails	08-Sep-2014	0	Camarillo
7 HTRB_150°C _0408	105	Pass on Zero Fails	22-Sep-2014	0	Camarillo
8 HTS_Pre_Elect	77	Pass on Zero Fails	05-Sep-2014	0	Camarillo
9 HTS_0168	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo
10 HTS_0500	77	Pass on Zero Fails	26-Sep-2014	0	Camarillo
11 HTS_1000	77	Pass on Zero Fails	21-Oct-2014	0	Camarillo
13 Pre_Elect_Precond	77	Pass on Zero Fails	10-Sep-2014	0	Camarillo
14 Precond_Temp_Cyc_5cyc	77	Pass on Zero Fails	10-Sep-2014	0	Camarillo
15 Precond_HTS_24hr	77	Pass on Zero Fails	11-Sep-2014	0	Camarillo
16 Precond_85/85_NoElec168hr	77	Pass on Zero Fails	18-Sep-2014	0	Camarillo
17 Precond_IR_Refl_Char	77	Pass on Zero Fails	18-Sep-2014	0	Camarillo
18 T/C_Pre_Elect	77	Pass on Zero Fails	18-Sep-2014	0	Camarillo
19 T/C_wPre_0250	77	Pass on Zero Fails	23-Sep-2014	0	Camarillo
20 T/C_wPre_0500	77	Pass on Zero Fails	29-Sep-2014	0	Camarillo
21 T/C_wPre_1000	77	Pass on Zero Fails	09-Oct-2014	0	Camarillo
22 85/85_Pre Elec	77	Pass on Zero Fails	05-Sep-2014	0	Camarillo
23 85/85_Biased_168hr	77	Pass on Zero Fails	12-Sep-2014	0	Camarillo
24 85/85_on/off500hrs	77	None	26-Sep-2014	0	Camarillo
25 85/85_on/off_1000hrs	77	None	21-Oct-2014	0	Camarillo
26 Pack_Clos	0	0	22-Oct-2014	0	Camarillo

# TgnLqd'FgwchdTgrqtv

Dwukp guuwp kv	Protection			
Tgdqd%	RctvaPwo dgt.'Lqd'Pco gIV{rg	Hcd.'Rcemcig	TgnLqd'Ux wu	Mg{'F c vgu<
5884	RClamp2451ZA	Tower	Active Rel Job	Lqd'Ceegrugf < 09-Sep-2014
	RClamp2451ZA New Device Qual	SLP0603P2X3F		<i>Tgs wgungf 'EF&lt;</i> <i>CewwcnUwcty'F c vg</i> <01-Oct-2014
	New Product on qualified process and qualified package		"	GEF 'hqt 'Eqpf lolqp cıκ
<i></i>				' <i>Lqd'GEF</i> <23-Oct-2014

Eqo r ıgvgf 'Vc umu					
1.0 Nqv AER2065 Cuugo dr(N	<i>qv</i> AER-002065	FcvgEqfg	1439		
Ugs VcunEqfg	Uco rıgUk g	Et kgt kc	Eqorngug 1	Hc knwt gu	FcwUqwteg TguwnuEqo o gpчи
1 Data-Prep	None	None	01-Oct-2014	0	Camarillo
2 HTRB_Pre_Elect_150°C_RT24	210	Pass on Zero Fails	01-Oct-2014	0	Camarillo
3 HTRB_150°C_Real Time_0024	210	Pass on Zero Fails	22-Oct-2014	0	Camarillo
4 HTRB_Pre_Elect	105	Pass on Zero Fails	01-Oct-2014	0	Camarillo
5 BI_BD_Valid	NA	Meet HTOL Schematics	01-Oct-2014	0	Camarillo
6 HTRB_150°C_0072	105	Pass on Zero Fails	06-Oct-2014	0	Camarillo
7 HTRB_150°C _0408	105	Pass on Zero Fails	20-Oct-2014	0	Camarillo
8 85/85_Pre Elec	20	Pass on Zero Fails	01-Oct-2014	0	Camarillo
9 85/85_120hr_On/Off	20	Pass on Zero Fails	06-Oct-2014	0	Camarillo
10 Pack_Clos	0	0	23-Oct-2014	0	Camarillo

#### *Y* gf p guf c {. 'Qevqdgt '44. '4236

Businessunit	Protection			
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:
5929	RClamp1851ZA	Tower	Rel Testing Complete	Job Accepted: 21-Jan-2015
	New Device Qual	SLP0603P2X3F	Passes All Requirements	Requested CD:
	New Product on qualified process and qualified package			Actual Start Date: 17-Dec-2014 ECD for Conditional:
	· · · ·			Job ECD: 19-Mar-2015

		Completed 14	SKS	
1.0 Lot AER2241 As	semblyLot AER2241	DateCode	1504	
Seq TaskCode	SampleSize	Criteria	Complete Failures	DataSource Results/Comments
1 Data-Prep	None	None	19-Feb-2015	Camarillo
2 HTRB_Pre_Elect_150°C_RT	24 210	Pass on Zero Fails	20-Feb-2015 0	Camarillo
3 HTRB_150°C_Real Time_00	24 210	Pass on Zero Fails	06-Mar-2015 0	Camarillo
4 HTRB_Pre_Elect	105	Pass on Zero Fails	19-Feb-2015 0	Camarillo
5 HTRB_150°C_0072	105	Pass on Zero Fails	23-Feb-2015 0	Camarillo
6 HTRB_150°C _0408	105	Pass on Zero Fails	06-Mar-2015 0	Camarillo
7 85/85_Pre Elec	20	Pass on Zero Fails	19-Feb-2015 0	Camarillo
8 85/85_120hr_On/Off	20	Pass on Zero Fails	24-Feb-2015 0	Camarillo
9 Pack_Clos	0	0	07-Mar-2015	Camarillo

#### **Completed Tasks**

Businessunit	Protection			
Reljob#	Part_Number, Job Name/Type	Fab, Package	Rel Job Status	Key Dates:
5930	RClamp3331ZA	Tower	Finished Creating	Job Accepted: 21-Jan-2015
	New Device Qual	SLP0603P2X3F	Reliability Test Plan	Requested CD:
New Product on qualified proce qualified package	New Product on qualified process and qualified package			Actual Start Date: 17-Dec-2014 ECD for Conditional:
				Job ECD: 19-Mar-2015

Completed Tasks					
1.0 Lot AER2243 A	ssemblyLot AER2243	DateCode	1504		
Seq TaskCode	SampleSize	Criteria	Complete F	ailures	DataSource Results/Comments
1 Data-Prep	None	None	19-Feb-2015		Camarillo
2 HTRB_Pre_Elect_150°C_RT	24 210	Pass on Zero Fails	20-Feb-2015	0	Camarillo
3 HTRB_150°C_Real Time_00	24 210	Pass on Zero Fails	27-Feb-2015	0	Camarillo
4 HTRB_Pre_Elect	105	Pass on Zero Fails	19-Feb-2015	0	Camarillo
5 HTRB_150°C_0072	105	Pass on Zero Fails	23-Feb-2015	0	Camarillo
6 HTRB_150°C _0408	105	Pass on Zero Fails	06-Mar-2015	0	Camarillo
7 85/85_Pre Elec	20	Pass on Zero Fails	19-Feb-2015	0	Camarillo
8 85/85_120hr_On/Off	20	Pass on Zero Fails	24-Feb-2015	0	Camarillo
9 Pack_Clos	0	0	09-Mar-2015		Camarillo

#### Thursday, March 19, 2015